

## **EMC Test Report**

# CE

Applicant :	eten Technologies Inc.
Address of Applicant :	2F, No.6, Lane 497, Zhongzheng Road, Xindian Dist., New Taipei City 231, Taiwan,
Equipment Under Test :	R.O.C. 24-Port 10/100/1000Base-T + 2-Port 10G SFP+ Stackable Layer 2+ Full Management High Power PoE Switch
Model Number :	PSG-6526XS
Series :	PSG-6528, PSG-652Y(Y=0~9)

Matrix Test Laboratory 2F, No.146, Jian Yi Rd., Chung-Ho District, New Taipei City, Taiwan, R.O.C. TEL. : +886 2 2228-6610 FAX. : +886 2 2228-6580

## **Contents**

1	General Description	8
1.1	Description of Equipment Under Test (EUT)	8
1.2	Test Facility	9
1.3	Test Instruments	9
1.4	Test Methodology	10
1.5	Auxiliary Equipments	11
1.6	Block Diagram	11
1.7	Identifying the Final Test Mode (Worst Case)	11
1.8	Final Test Mode	11
1.9	Condition of Power Supply	12
1.10	EUT Configuration	12
1.11	Immunity Performance Classification	12
2	Conducted Disturbance Test (at Mains Terminal)	13
2.1	Test Instruments	13
2.2	Test Arrangement and Procedure	13
2.3	Test Limit	14
2.4	Test Result	14
3	Conducted Disturbance Test (at Telecommunication Ports)	17
3.1	Test Instruments	17
3.2	Test Arrangement and Procedure	17
3.3	Conducted Limit	18
3.4	Test Result	18
4	Radiated Disturbance Test – Below 1 GHz	20
4.1	Test Instruments	20
4.2	Test Arrangement and Procedure	20
4.3	Test Limit	20
4.4	Test Result	20
5	Radiated Disturbance Test – Above 1 GHz	23
5.1	Test Instruments	23
5.2	Test Configuration and Procedure	23
5.3	Test Limit	24
5.4	Test Result	24
6	Harmonic Current Emission Measurement	27
6.1	Test Instruments	27

Report N	o.:R13111404E	Mehirlx
6.2	Test Configuration and Procedure	27
6.3	EUT Operation Condition	27
6.4	Test Limit	28
6.5	Test Result	28
7	Voltage Fluctuations and Flicker Measurement	30
7.1	Test Instruments	30
7.2	Test Configuration and Procedure	30
7.3	EUT Operation Condition	30
7.4	Test Limit	30
7.5	Test Result	30
8	Electrostatic Discharge Immunity Test	32
8.1	Test Instruments	32
8.2	Test Configuration and Procedure	32
8.3	Test Result	33
9	Radio-frequency, Electromagnetic Field Immunity Test	34
9.1	Test Instruments	34
9.2	Test Configuration and Procedure	34
9.3	Test Result	35
10	Electrical Fast Transient Test	36
10.1	Test Instrument	36
10.2	Test Configuration and Procedure	36
10.3	Test Result	37
11	Surge Immunity Test	38
11.1	Test Instrument	38
11.2	Test Configuration and Procedure	38
11.3	Test Result	39
12	Radio-frequency, Conducted Disturbances Immunity Test	40
12.1	Test Instruments	40
12.2	Test Configuration and Procedure	40
12.3	Test Result	41
13	Power Frequency Magnetic Field Immunity Test	42
13.1	Test Instruments	42
13.2	Test Configuration and Procedure	42
13.3	Test Result	43
14	Voltage Dips, Short Interruptions Immunity Test	44
14.1	Test Instrument	44
14.2	Test Configuration and Procedure	44

Report No	.:R13111404E	M@rirlx
14.3	Test Result	45
15	Photographs of Test	46
15.1	Conducted Disturbance Test(at Mains Terminals)	46
15.2	Telecommunication Port Conducted Test	47
15.3	Radiated Disturbance Test – Below 1 GHz	48
15.4	Radiated Disturbance Test – Above 1 GHz	49
15.5	Harmonic Current & Voltage Fluctuations and Flicker Measurement	50
15.6	Electrostatic Discharge Immunity Test	50
15.7	Radio-frequency, Electromagnetic Field Immunity Test	51
15.8	Electrical Fast Transient / Burst Immunity Test	51
15.9	Surge Immunity Test	52
15.10	Radio-frequency, Conducted Disturbances Immunity Test	52
15.11	Power Frequency Magnetic Field Immunity Test	53
15.12	Voltage Dips, Short Interruptions Immunity Test	53
16	Photographs of EUT	54
17	Photographs of ESD Test Points	61

## Verification

Applicant :	eten Technologies Inc.		
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Manufacturer :	eten Technologies Inc.		
	24-Port 10/100/1000Base-T + 2-Port 10G SFP+		
Equipment Under Test :	Stackable Layer 2+ Full Management High Power		
	PoE Switch		
Model Number :	PSG-6526XS		
Series :	PSG-6528, PSG-652Y(Y=0~9)		
Sample Received Date :	2013-11-14		
Test Standard :			
Emission:	Immunity:		
🖾 EN 55022:2010 Class A	🖾 EN 55024:2010		
🖂 IEC 61000-3-2:2005	IEC 61000-4-2:2008		
+A1:2008+A2:2009	IEC 61000-4-3:2006+A1:2007+A2:2010		
🖂 IEC 61000-3-3:2008	IEC 61000-4-4:2004+A1:2010		
	IEC 61000-4-5:2005		
	IEC 61000-4-6:2008		
	IEC 61000-4-8:2009		
	IEC 61000-4-11:2004		

#### **Remark:**

This report details the results of the test carried out on one sample. This report shows the EUT is technically compliant with the EN 55022 and EN 55024 official requirements. This report applies to the above sample only and shall not be reproduced in part without written approval of Matrix Test Laboratory.

lody Peng

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Approved by:

**Date:** 2013-11-25

2013-11-22

Date:

Peter Chin/ Head of Laboratory

CE EMC Testing Report

**Date:** 2013-11-25

## **Summary of Test Result – Emission**

Test Standard	Test Item	Test Result	Remark
EN55022 Class A	Conducted Disturbance Test (at Mains Terminal)	Pass	Highest Emission L: 1.725MHz, Q.P.56.79dBuV, Margin -16.07 dB N: 1.725MHz, Q.P.55.68dBuV, Margin -17.20 dB
EN55022 Class A	Conducted Disturbance (at Telecommunic ation Ports)	Pass	Highest Emission Voltage: 2.931MHz, Q.P.63.11dBuV, Margin -14.26 dB A.V.63.25dBuV, Margin -1.12 dB
EN55022 Class A	Radiated Disturbance Test (Below 1GHz)	Pass	Highest Emission H: 253.100MHz, 60.17dBuV, Margin-1.43 dB Antenna Height 2.15 m, Turntable Angle 148° V: 127.000MHz, 53.11dBuV, Margin-2.88 dB Antenna Height 1 m, Turntable Angle 335°
EN55022 Class A	Radiated Disturbance Test (Above 1GHz)	Pass	Highest Emission H: 1035.000MHz, 53.16dBuV, Margin-11.97 dB Antenna Height 3.85 m, Turntable Angle 222° V: 1500.000MHz, 60.23dBuV, Margin-6.57 dB Antenna Height 1.99 m, Turntable Angle 347°
IEC61000-3-2	Harmonic	Pass	Refer to Page 27
IEC61000-3-3	Flicker	Pass	Refer to Page 30

## **Measurement Uncertainty – Emission**

The following measurement uncertainty has been calculated for Emission Tests performed on the EUT as specified in CISPR 16-4-2:

Test Item		Uncertainty	
Conducted Emission		± 3.61dB	
Radiated Emission	Below 1GHz	± 5.04dB	
	Above 1GHz	± 4.97dB	

This reported expanded uncertainty is based on a standard uncertainty multiplied by a coverage factor of k = 2, providing a level of confidence of approximately 95%.

Test Standard	Test Item	Performance Criteria	Observed Result Class	Test Result	
IEC61000-4-2	Electrostatic Discharge	В	А	Pass	
IEC61000-4-3	Radiated Susceptibility	А	А	Pass	
IEC61000-4-4	Electrical Fast Transient	В	А	Pass	
IEC61000-4-5	Surge	В	А	Pass	
IEC61000-4-6	Conducted Susceptibility	А	А	Pass	
IEC61000-4-8	Magnetic Field	А	А	Pass	
		Dips >95% B	А		
		Dips 30% C	А	Deee	
IEC61000-4-11	Voltage Dips and Interruption	Interruptions >95% C	В	Pass	

## **Measurement Uncertainty – Immunity**

It has been demonstrated that the test equipments for the above Immunity Tests meet the specified requirements in the standard with at least a 95% confidence.

#### **1** General Description

#### **1.1** Description of Equipment Under Test (EUT)

Equipment Under Test		24-Port 10/100/1000Base-T + 2-Port 10G SFP+ Stackable Layer 2+ Full Management High Power PoE Switch		
Model Number	:	PSG-6526XS		
Series	:	PSG-6528, PSG-652Y(Y=0~9)		
Applicant Address of Applicant		eten Technologies Inc. 2F, No.6, Lane 497, Zhongzheng Road, Xindian Dist., New Taipei City 231, Taiwan, R.O.C.		
Manufacturer Address of Manufacturer	:	eten Technologies Inc. 2F, No.6, Lane 497, Zhongzheng Road, Xindian Dist., New Taipei City 231, Taiwan, R.O.C.		
Power Supply	:	Input: 100-240Vac, 60 / 50Hz Output: 56Vdc, 4.46A, Max. 500W		
Data Cable	:	⊠N/A		
Data Cable		<ul> <li>Dimensions : 44 cm (L) X 33 cm (W) X 4.5 cm (H)</li> <li>Weight : 4.8 Kg</li> <li>Highest Frequency of the Internal Source : 125 MHz</li> <li>Position : ⊠Table-top / □Floor-standing</li> <li>Intended Function : The EUT is a 24-Port 10/100/1000Base-T + 2-Port 10G SFP+ Stackable Layer 2+ Full Management High Power PoE Switch.</li> <li>Product Variance : The manufacturer declares that the series products share the identical circuit design with the main test sample. The main test sample is the most sophisticated product with full functions. The series products have less function than the main test sample.</li> </ul>		

#### 1.2 Test Facility

Conducted Emission, Harmonic, Flicker, Electrostatic Discharge, Electrical Fast Transient, Surge, Conducted Susceptibility, Voltage Dips and Interruptions Tests are performed at 2F, No.146, Jian Yi Rd., Chung-Ho District, New Taipei City, Taiwan, R.O.C.

Radiated Emission, Radiated Susceptibility, Magnetic Field Tests are performed at No. 15-1, Cweishuh Keng, Cweipin Village, Linkou, New Taipei City, Taiwan, R.O.C.

#### 1.3 Test Instruments

#### Instruments Used for Emission Measurement

Instrument	Manufacturer	Model	Serial No.	Calibration Date	Application
L.I.S.N.	Mess Tec	NNB-2/16Z	03/1006	2013-05-12	
L.I.S.N.	EMCIS	LN2-16	LN04023	2013-02-13	Conducted Disturbance
Pulse Limiter	Mess Tec	PL10	N/A	2012-11-30	Conducted Disturbance
RF Cable	N/A	N/A	N/A	2013-10-05	
Coupling AND Decoupling Network	SCHAFFNER	ISN T400	16832	2013-10-08	Conducted Disturbance at Telecommunication
RF Current Probe	FCC	F-33-4	53	2013-05-16	Port
EMI Receiver	R&S	ESCI	100615	2013-02-13	Conducted Disturbance Radiated Disturbance (Below 1GHz)
Bilog Antenna	Teseq GmbH	CBL6111D	25769	2013-02-06	
Pre-Amplifier	WIRELESS	FPA-6592G	60009	2013-07-08	Radiated Disturbance
Spectrum Analyzer	R & S	FSL6	100564	2013-06-15	(Below 1GHz)
RF Cable	MIYAZAKI	8D-F8	N/A	2013-02-08	
Double-Ridged Waveguide Horn	EMCO	3115	9912-5992	2013-05-14	
Preamplifier	HD	HD17187	004	2013-08-02	Radiated Disturbance
Spectrum Analyzer	ADVANTEST	R3172	101202158	2013-06-23	(Above 1GHz)
Coaxial Cable	HUBER SUHNER	SUCOFLEX 104	197541/4	2013-08-02	
Programmable AC Source	Chroma	6520	2048	2013-01-31	Harmonia Eliakor
Universal Power Analyzer	Chroma	6630	0597	2013-01-31	Harmonic, Flicker

Instruments Used	for immunity	weasurement			
Instrument	Manufacturer	Model	Serial No.	Calibration Date	Application
ESD Simulator	Noiseken	TC-815R	ESS0868491	2012-12-14	Electrostatic
ESD Simulator	Noiseken	ESS-2002EX	ESS0868406	2012-12-14	Discharge
Antenna	EMCO	3142	9710-1221	2013-02-11	
Power Amplifier	IFI	CMX50	N/A	2013-02-07	Radiated Immunity
Signal Generator	R&S	SML03	103396	2013-02-01	
CDN	FRANKONIA	CDN M2+M3	A3011037	2013-07-08	
C.I. Test System	FRANKONIA	CIT-10/75	102C3208	2012-12-27	Conducted
Power Attenuator	FRANKONIA	75-A-FFN-06	0212	2012-12-27	Immunity
RF Cable	N/A	N/A	N/A	2012-11-30	
Antenna	FCC	F-1000-4-8/9/10-L-1M	9953	2013-03-02	
Advanced EMC					Magnetic Field
Immunity Test	KEYTEK	EMC PRO	0002255	2013-03-02	Disturbance
System					
					Electrostatic
	EMC				Discharge,
Transient 2000	PARTNER	TRA-2000	449	2013-11-09	Fast Transient,
	FARINER				Surge,
					Dips & Interruptions

**Instruments Used for Immunity Measurement** 

Note: The instruments listed above are within their calibration period of 1 year.

#### 1.4 Test Methodology

All Emission Tests were performed according to the procedures specified in EN 55022. All Immunity Tests were performed according to the procedures specified in EN 55024.

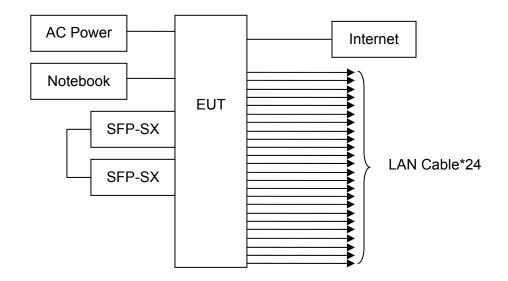


#### 1.5 Auxiliary Equipments

Provided by Matrix Test Lab.

No.	Equipment	Equipment Model No. Serial No. EMC		EMC	Brand	Power Cord	
110.	Equipment	model No.		Approved	Drand		
1	Notebook	N61J	N61JV-021A520M	CE,FCC, C-TICK N13219, BSMI R31018	ASUS	N/A	
2	SFP-SX	JS-S430LX	JS129190003	N/A	JUMBO-SUN	N/A	
3	SFP-SX	JS-S430LX	JS129190004	N/A	JUMBO-SUN	N/A	

#### 1.6 Block Diagram



#### 1.7 Identifying the Final Test Mode (Worst Case)

1. Operation Mode : Run Ping IP testing program

Note: After pre-test, we identified that the Operation Mode (the worst case) was most likely to cause maximum disturbance and most likely to be susceptible to disturbance. Therefore, the Final EMC Assessment was performed for the worst case.

#### 1.8 Final Test Mode

**Operation Mode** 

#### 1.9 Condition of Power Supply

AC 230V, 50Hz

#### 1.10 EUT Configuration

- 1. Setup the EUT as shown in Sec.1.6 Block Diagram.
- 2. Turn on the power of all equipments.
- 3. Activate the selected Final Test Mode.

#### 1.11 Immunity Performance Classification

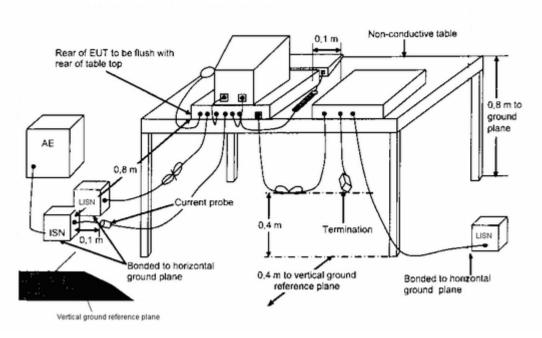
Class	Class Criterion
	The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.
В	After the test, the equipment shall continue to operate as intended without operator intervention.
С	Lost of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the user in accordance with the manufacturer's instructions.

#### 2 Conducted Disturbance Test (at Mains Terminal)

#### 2.1 Test Instruments

Refer to Sec. 1.3 Test Instruments.

#### 2.2 Test Arrangement and Procedure



#### **Table-top Equipment**

- The EUT was placed on a non-conductive table which was 80 cm above the horizontal coupling plane. The rear of the EUT was 40 cm from the vertical coupling plane.
- The excess interface cables were folded at the cable center into a bundle no longer than 40 cm, so that the bundles were on the table.
- The EUT was connected to the main power through a L.I.S.N. This set up provided 50 ohm / 50 μH coupling impedance for the measuring equipment.
- All auxiliary equipment received power from a second L.I.S.N.
- The conducted emissions were measured between the Line Phase and the PE ground and between the Neutral Phase and the PE ground using an EMI Receiver.
- The values were recorded.

#### 2.3 Test Limit

EN 55022

	🖂 CI	ass A	Class B		
Frequency (MHz)	Q.P. (Quasi-Peak)	A.V. (Average)	Q.P. (Quasi-Peak)	A.V. (Average)	
0.15 ~ 0.50	79	66	66 to 56	56 to 46	
0.50 ~ 5.0	73	60	56	46	
5.0 ~ 30	73	60	60	50	

The EMI Receiver bandwidth was set at 9 kHz.

#### 2.4 Test Result

#### PASS

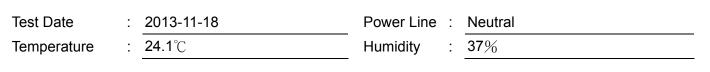
The final test data are shown on the following page(s)

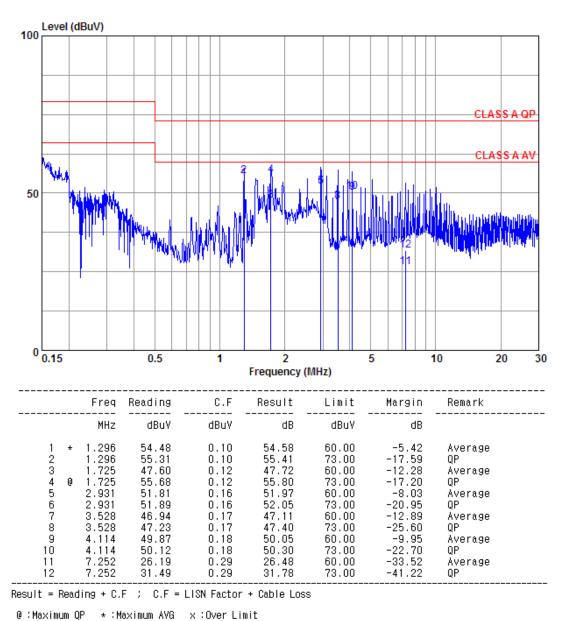
#### Test Date : 2013-11-18 Power Line : Line : 37% Temperature : **24.1**°C Humidity Level (dBuV) 100 CLASS A QP CLASS A AV APRILING THE AND THE APPINE 50 <sup>0</sup>0.15 0.5 1 2 5 10 20 30 Frequency (MHz) \_\_\_\_\_ \_\_\_\_\_ \_\_\_\_\_ \_\_\_\_ Freq Reading C.F Result Limit Margin Remark \_\_\_\_\_ MHz dBuV dBuV dB dBuV dB 1.296 54.33 0.12 54.45 60.00 -5.55 1 \* Average 2 3 1.296 54.69 0.12 54.81 73.00 -18.19 QP 1.725 50,90 0.14 51.04 60.00 -8.96 Average 4 0 56.79 0.14 56.93 73.00 -16.07QP 5 2.931 0.17 53.20 60.00 Average 53.03 -6.80 6 7 2,931 53.43 0.17 53,60 73.00 -19.40 QP 0.17 -10.36 -23.51 -7.35 60.00 73.00 3.528 49.47 49.64 Average 49.49 52.65 52.71 3.528 49.32 ŨΡ 8 52.47 52.53 27.92 60.00 73.00 ġ 0.18 Äverage 4.114 -20.29 QP 10 4.114 0.18 28.21 60.00 73.00 0.29 Average 11 7.252 7.252 12 32.03 0.29 32.32 -40.68ΩP. Result = Reading + C.F ; C.F = LISN Factor + Cable Loss @ :Maximum QP + :Maximum AVG x :Over Limit

#### **Conducted Emission Test Data**

Remark : All readings are Quasi-Peak and Average values.

#### **Conducted Emission Test Data**





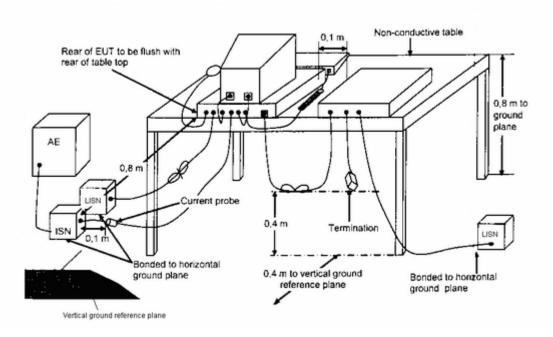
Remark : All readings are Quasi-Peak and Average values.

3

#### 3.1 Test Instruments

Refer to Sec. 1.2 Test Instruments.

#### 3.2 Test Arrangement and Procedure



#### Table-top Equipment

- The EUT was placed 0.4 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network(LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/50µH of coupling impedance for the measuring instrument.
- Interconnecting cables that hang closer than 40cm to the ground plane shall be folded back and forth in the center forming a bundle no longer than 40cm.
- I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1m.
- ISN at least 80cm from nearest part of EUT chassis.
- The communication function of EUT was executed and ISN was connected between EUT and associated equipment and the ISN was connected directly to reference ground plane.

Page 17 of 62

#### 3.3 Conducted Limit

Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15MHz to 30MHz for class A equipment.

Frequency (MHz)	Voltage Limits dB( $\mu$ V)Current Limits dB( $\mu$ A)			
Frequency (MHz)	Q.P. (Quasi-Peak)	A.V. (Average)	Q.P. (Quasi-Peak)	A.V. (Average)
0.15 ~ 0.5	97 to 87	84 to 74	53 to 43	40 to 30
0.5 ~ 30	87	74	43	30

NOTE1: The limits decrease linearly with the logarithm of the frequency in the range 0.15MHz to 0.5MHz.

NOTE2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150  $\Omega$  to the telecommunication port under test (conversion factor is 20 log10 150/I=44dB)

Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15MHz to 30MHz for class B equipment.

	Voltage Lin	nits dB(μV)	Current Limits dB(µA)		
Frequency (MHz)	Q.P. (Quasi-Peak)	A.V. (Average)	Q.P. (Quasi-Peak)	A.V. (Average)	
0.15 ~ 0.5	84 to 74	74 to 64	40 to 30	30 to 20	
0.5 ~ 30	74	64	30	20	

NOTE1: The limits decrease linearly with the logarithm of the frequency in the range 0.15MHz to 0.5MHz.

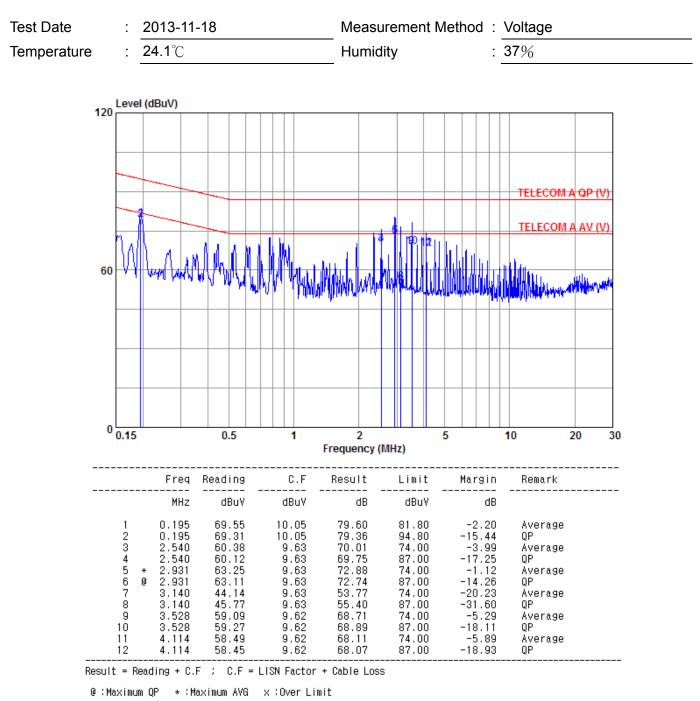
NOTE2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150  $\Omega$  to the telecommunication port under test (conversion factor is 20 log10 150/I=44dB)

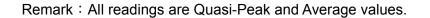
#### 3.4 Test Result

#### PASS

The final test data are shown on the following page(s).

#### **Conducted Disturbance Test Data**



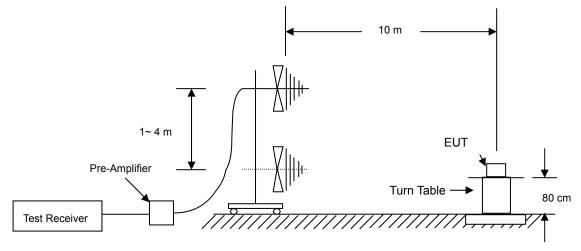


#### 4 Radiated Disturbance Test – Below 1 GHz

#### 4.1 Test Instruments

Refer to Sec. 1.3 Test Instruments.

#### 4.2 Test Arrangement and Procedure



#### **Table-top Equipment**

- The EUT was place on a non-conductive turntable which was 80 cm above the horizontal ground plane. The EUT was set 10 m away from the receiving antenna that was mounted on a non-conductive mast.
- Main cables draped to the ground plane and were routed to the mains power outlet. The mains power outlet was bonded to and did not protrude above the ground plane.
- The antenna was adjusted between 1 m and 4 m in height above the ground plane and the Antenna-to-EUT azimuth was also varied during the measurements to find the top 6 maximum meter readings within the frequency range limit as indicated in Sec 3.3.
- The radiated emissions were measured when the Antenna-to-EUT polarization was set horizontally and vertically.
- The values were recorded.

#### 4.3 Test Limit

🖾 EN 55022

Frequency (MHz)	🛛 Class A	Class B	
	Quasi-Peak (dBuV/m)	Quasi-Peak (dBuV/m)	
30 ~ 230	40.0	30.0	
230 ~ 1000	47.0	37.0	

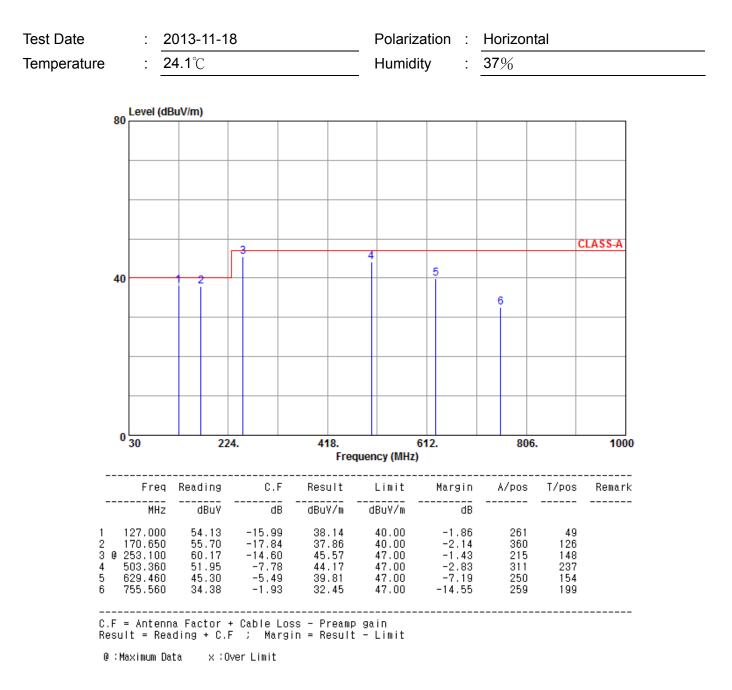
The EMI test receiver bandwidth was set at 120 kHz.

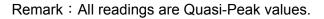
#### 4.4 Test Result

#### PASS

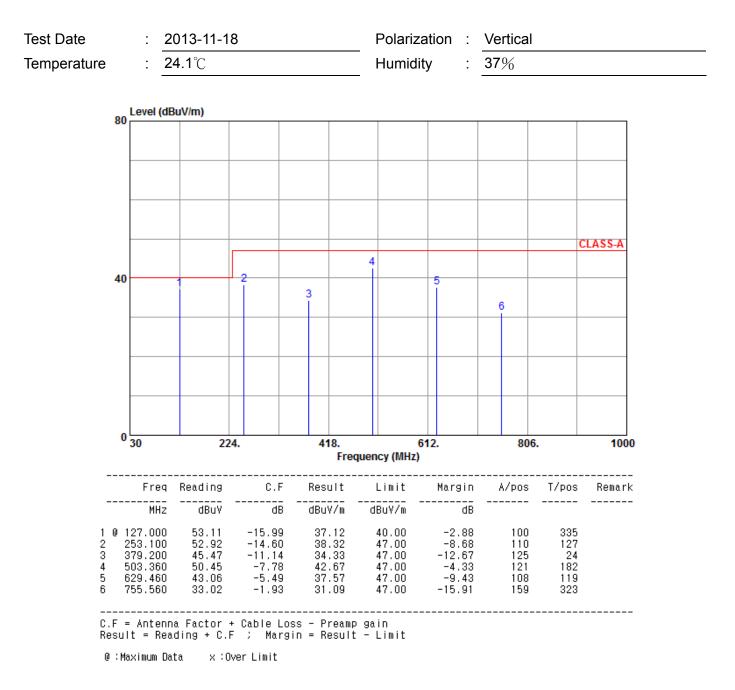
The final test data are shown on the following page(s).

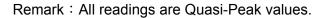
#### **Radiated Emission Test Data**





#### **Radiated Emission Test Data**



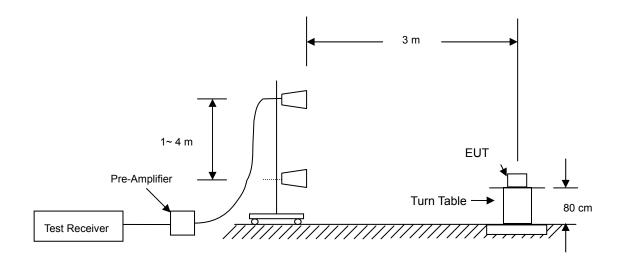


#### 5 Radiated Disturbance Test – Above 1 GHz

#### 5.1 Test Instruments

Refer to Sec. 1.3 Test Instruments.

#### 5.2 Test Configuration and Procedure



#### Table-top Equipment

- The EUT was place on a non-conductive turntable which was 80cm above the horizontal ground plane. The EUT was set 3m away from the receiving antenna that was mounted on a non-conductive mast.
- Main cables draped to the ground plane and were routed to the mains power outlet. The mains power outlet was bonded to and did not protrude above the ground plane.
- The antenna was adjusted between 1m and 4m in height above the ground plane and the Antenna-to-EUT azimuth was also varied during the measurements to find the top 6 maximum meter readings within the frequency range limit as indicated in Sec 4.3.
- The radiated emissions were measured when the Antenna-to-EUT polarization was set horizontally and vertically.
- The values were recorded.

#### 5.3 Test Limit

EN55022 Class A ITE at a measurement distance of 3m

Frequency	Average limit	Peak limit			
GHz	dB(µV/m)	dB(µV/m)			
1 to 3	56	76			
3 to 6 60 80					
NOTE The lower limit applies at the transition frequency.					

#### EN55022 Class B ITE at a measurement distance of 3m

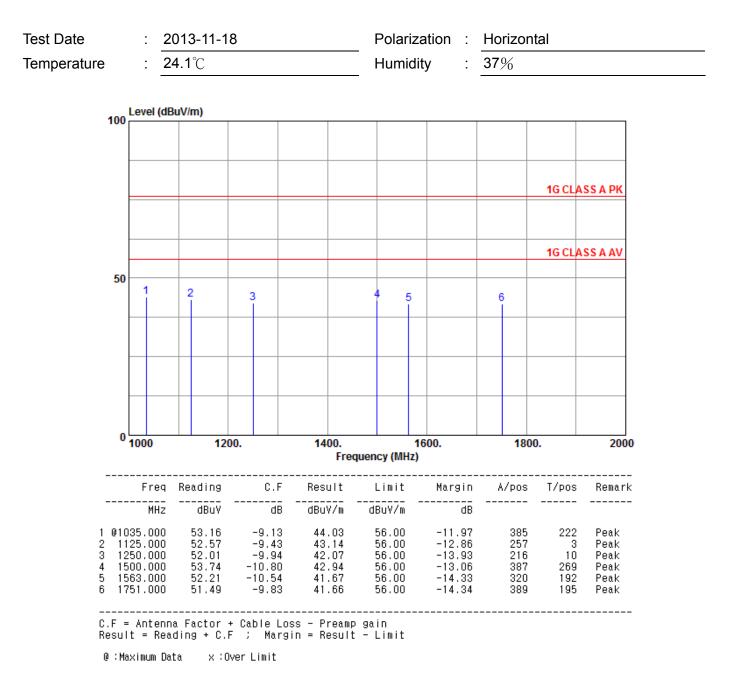
Frequency	Average limit	Peak limit			
GHz	dB(μV/m)	dB(µV/m)			
1 to 3	50	70			
3 to 6 54 74					
NOTE The lower limit applies at the transition frequency.					

#### 5.4 Test Result

#### PASS

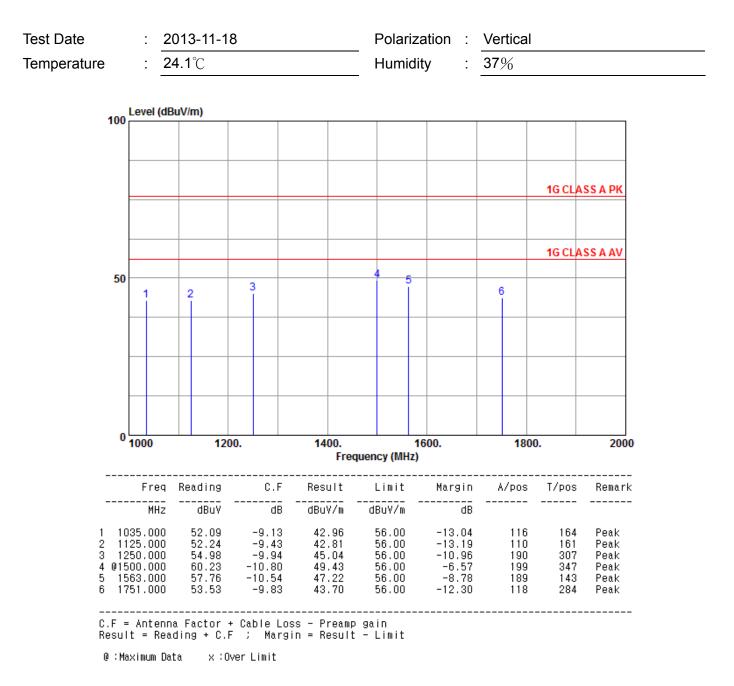
The final tests data are shown on the following page(s).

#### **Radiated Emission Test Data**



Remark : All readings are Peak values. None of the peak value reading exceeds the A.V. limit. Hence, A.V. reading was not measured.

#### **Radiated Emission Test Data**

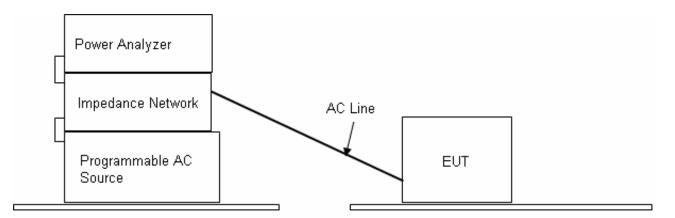


Remark : All readings are Peak values. None of the peak value reading exceeds the A.V. limit. Hence, A.V. reading was not measured.

6.1

Refer to Sec. 1.3 Test Instruments.

#### 6.2 Test Configuration and Procedure



- The EUT was set in series with the Power Analyzer through an Impedance Network for the measurement of harmonic currents.
- The supply voltage and frequency setting on the Programmable AC Source was programmed as the rated voltage and frequency of the EUT.
- Classify the EUT class in accordance with the IEC61000-3-2 for the purpose of harmonic current limitation. The measurement was automatically performed by test software. The test result was collected and analyzed by the computer.

#### 6.3 EUT Operation Condition

Environment Condition

Temperature Humidity		Atmospheric Pressure	
<b>24</b> .1℃	37%RH	1017mbar	

#### 6.4 Test Limit

Class A Equipment

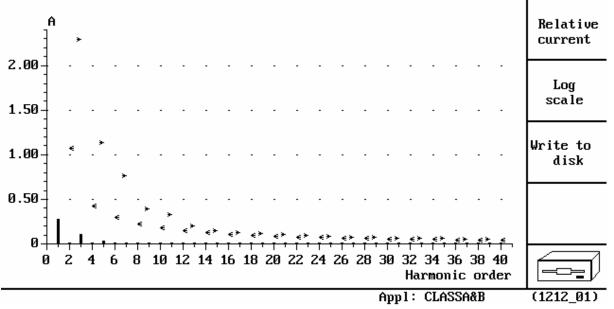
Harmonic Order (n)	Maximum permissible harmonic current (A)					
	Odd harmonics					
3	2.30					
5	1.14					
7	0.77					
9	0.40					
11	0.33					
13	0.21					
15 ≤ n ≤ 39	0.15 * 15 / n					
	Even harmonics					
2	1.08					
4	0.43					
6	0.30					
8 ≤ n ≤ 40	0.23 * 8 / n					

#### 6.5 Test Result

#### PASS

The measured result is shown on the following page(s).

Chroma	ſ	A	NALYZER 663	30	2013.11.15	16:50:51
	Cur		Harmo			Next measure
Setup: CLASSA Live Module: M1	Analı Limi Note	t: Class A :	.(1) U : ds: 4 I : (IEC1000) PF=0.574)	311.7 mA P	u: 50.000 Hz 2: 41.2 W 1: 284.4 mA	Change to bar graph
No A	Lim A	No	A Lim A	No A	I Lim A	Relative current
1 0.284		15 0.00		29 0.004		<b> </b>
2 0.000	1.080	16 0.00		30 0.001		
3 0.115	2.300	17 0.00		31 0.005		
40.000 50.040	0.430 1.140	18 0.00 19 0.00		32 0.001 33 0.008		
6 0.000	0.300	20 0.00		34 0.001		
7 0.007	0.770	21 0.00		35 0.004		Write to
8 0.001	0.230	22 0.00		36 0.001		disk
9 0.019	0.400	23 0.00		37 0.002		
10 0.001	0.184	24 0.00		38 0.001		
11 0.015	0.330	25 0.00		39 0.003		
12 0.000	0.153	26 0.00	1 0.071	40 0.001	0.046	
13 0.009	0.210	27 0.00				
14 0.000	0.131	28 0.00	1 0.066			
Current range:	1 Ap					╽╔══┚
				App l :	CLASSA&B	(1212_00)
Chroma	ſ	A	NALYZER 663	30	2013.11.15	16:51:05
Setup: CLASSA		rent setting: 1	Harmon		u: 50.000 Hz	Next measure
Live Analysed periods: 4 I : 311.7 mA P: 41.2 W Module: M1 Limit: Class A (IEC1000) I1: 284.4 mA Note: THD=44.46 % (PF=0.574) PASSED			': 41.2 ₩	Change to table		
Ĥ						   Relative



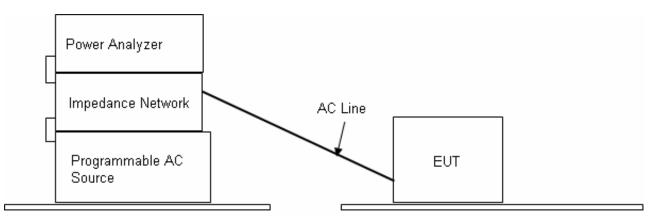
Note: The EUT power level is below 75watts therefore has no defined limits.

### 7 Voltage Fluctuations and Flicker Measurement

#### 7.1 Test Instruments

Refer to Sec. 1.3 Test Instruments.

#### 7.2 Test Configuration and Procedure



- The EUT was set in series with the Power Analyzer through an Impedance Network for the measurement of Flicker Voltage.
- The supply voltage and frequency setting on the Programmable AC Source was programmed as the rated voltage and frequency of the EUT.
- The measurement was automatically performed by test software. The test result was collected and analyzed by the computer.

#### 7.3 EUT Operation Condition

**Environment Condition** 

Temperature	Humidity	Atmospheric Pressure
<b>24</b> .1℃	37%RH	1017mbar

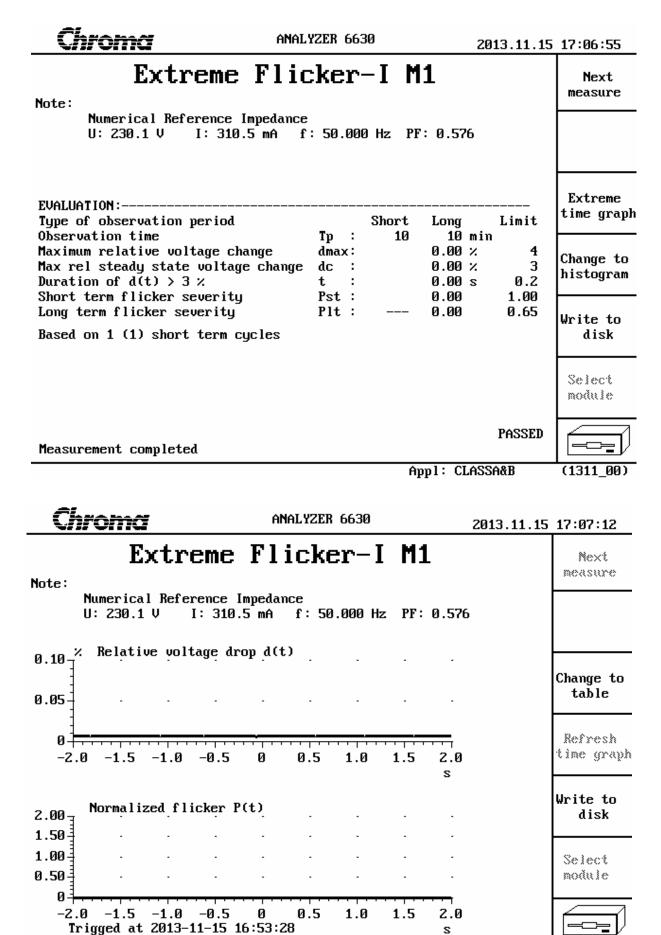
#### 7.4 Test Limit

Test Item	Limit	Remark		
Pst	1.0	Pst means short-term flicker indicator. $T_p$ =10 min		
Pit	0.65	Pit means long-term flicker indicator. Tp=2 hrs		
dt (%)	3.3	For more than 500ms		
dmax (%)	4	dmax means relative maximum voltage change.		
dc (%)	3.3	dc means relative steady-state voltage change.		

#### 7.5 Test Result

#### PASS

The measured result is shown on the following page(s).



Appl: CLASSA&B

s

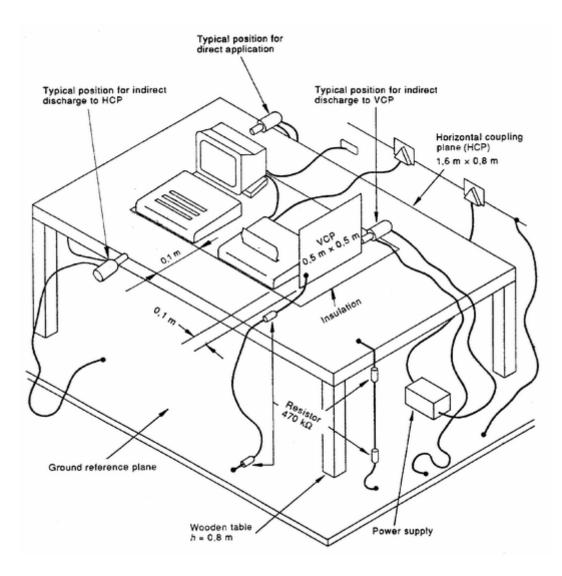
(13113\_00)

## 8 Electrostatic Discharge Immunity Test

#### 8.1 Test Instruments

Refer to Sec. 1.3 Test Instruments.

#### 8.2 Test Configuration and Procedure



#### **Table-top Equipment**

- The EUT was located on a 0.8 m high wooden table standing on the ground reference plane with a 1.6 \* 0.8 m horizontal coupling plane on the top. The EUT and cables was isolated from the coupling plane by an insulating support 0.5 mm thick.
- In Contact Discharge, the EUT was exposed to minimum 200 discharges, 100 each at negative and positive polarity on the selected test points ( the selected test points were marked with red labels on the EUT )
- In Air Discharge, the EUT exposed to minimum of 10 single discharges on the selected test points.
- The result was observed and analyzed.

#### 8.3 Test Result

#### 8.3.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure	
<b>24.1</b> ℃	37%RH	1017mbar	

8.3.2 Observation of Direct Discharge

Test Points: 1. Surface of Case. 2. Junction of Case. 3. PoE Ports. 4. SFP-SX Ports. 5. Screws.

6. AC Power Port. 7. LED Indicators. 8. Digital Display.

	Test Specifications				Performance		
Type of	Test	Polarity	Test	Number of	Required by	Observed	Verdict
Discharge	Level		Point	Discharge	EN55024	Result	verdici
Air	2,4,8	±	1~8	20/ per	В	А	Pass
Discharge	(kV)			point			
Contact	2,4	±	1~5	50/ per	В	А	Pass
Discharge	(kV)			point			
Remarks: 1. No temporary degradation or loss of function has been observed throughout							
the entire time interval of air discharge.							
2. No temporary degradation or loss of function has been observed throughout							
the entire time interval of contact discharge.							

The Performance Requirement Class Criterion is defined in Sec. 1.11.

## 8.3.3 Observation of Indirect Discharge

#### Test Points: 1. Front Side. 2. Rear Side. 3. Left Side. 4. Right Side.

	Test Specifications				Performance		
Type of	Test	Delority	Test	Number of	Required by	Observed	Verdict
Discharge	Level	Polarity	Point	Discharge	EN55024	Result	veruici
HCP	2,4	±	1~4	50/ per	В	А	Pass
Application	(kV)	<u>_</u>	1~4	point	В	Υ. Υ	F 855
VCP	2,4	±	1~4	50/ per	В	А	Pass
Application	(kV)	-	1/24	point	В	A	r ass
Remarks: 1. No temporary degradation or loss of function has been observed throughout							
the entire time interval of HCP application.							
2. No temporary degradation or loss of function has been observed throughout							

2. No temporary degradation or loss of function has been observed throughout the entire time interval of VCP application.

The Performance Requirement Class Criterion is defined in Sec. 1.11.

#### PASS

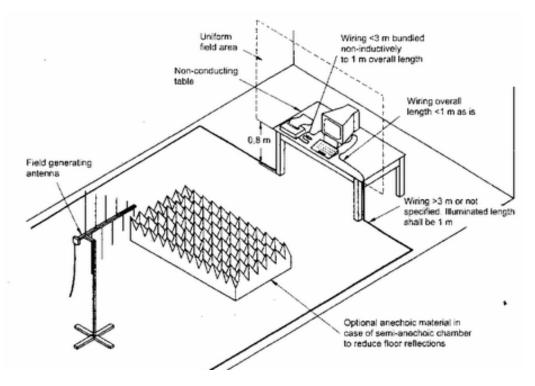
The test result shows that the EUT is in compliance with the test performance criteria specified in EN 55024.

### 9 Radio-frequency, Electromagnetic Field Immunity Test

#### 9.1 Test Instruments

Refer to Sec. 1.3 Test Instruments.

#### 9.2 Test Configuration and Procedure



#### Table-top Equipment

- The field calibration was executed to create a uniform field area (UFA), 3 m away from the antenna, to ensure the validity of the test results.
- The EUT was placed on a non-conductive table 0.8 m high in the UFA.
- The EUT was then connected to power and signal wires according to relevant installation instruction.
- The EUT was positioned so that the four sides of the EUT were exposed to the electromagnetic field in sequence. In each position, the performance of the EUT was investigated and monitored by a CCD camera..

#### 9.3 Test Result

#### 9.3.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure	
<b>24</b> .1℃	37%RH	1017mbar	

#### 9.3.2 Observation of Test

	-	Test Specifica	itions	Performance			
Type of	Field	Frequency	Modulation	Required by	Observed	Verdict	
Modulation	Strength	Range	Modulation	EN55024	Result	veruici	
Amplitude	3V/m	80 to	80%, 1KHz,	A	А	Pass	
Modulation	37/11	1000MHz	sinusoidal				
Remark:	No temporary degradation or loss of function has been observed throughout the						
	entire test.						

The Performance Requirement Class Criterion is defined in Sec. 1.11.

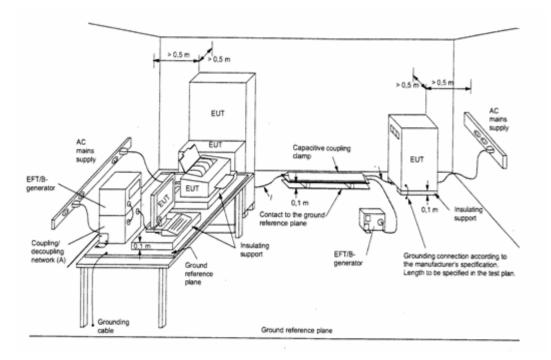
#### PASS

The test result shows that the EUT is in compliance with the test performance criteria specified in EN 55024.

#### 10.1 Test Instrument

Refer to Sec. 1.3 Test Instruments.

#### **10.2 Test Configuration and Procedure**



#### Table-top Equipment

- The EUT was placed on a table of 0.8 m height above the 1 \* 1 m metallic ground reference plane, which projected beyond the EUT by at least 0.1 m on all sides.
- The ground plane was connected to the protective earth.
- The distance between the EUT and all other conductive structures, except the ground plane beneath the EUT was more than 0.5 m.
- The length of the signal and power lies between the coupling device and the EUT was 0.5 m.
- All cables to the EUT were placed on the insulation support 0.1 m above the ground reference plane.
- The EUT was connected to the power mains through a coupling device that directly coupled the EFT interference signal. Each of the Line, Neutral and Protective Earth conductors was injected with burst for 1 minute. The test time was broken down into six 10 s bursts separated by a 10 s pause for avoiding synchronization. Both voltage polarities were applied for each test level.
- Operating condition was shown on the monitor and observed.

### 10.3 Test Result

### 10.3.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure	
<b>24</b> .1℃	37%RH	1017mbar	

### 10.3.2 Observation of Power Supply Port

		Test Speci	fications		Performance			
Coupling Selection	Voltage (kV)	Test Duration (Sec)	Repetition Rate (kHz)	Tr/ Td (nS)	Required by EN 55024	Observed Result	Verdict	
L	±1	60	5	5/50	В	А	Pass	
N	±1	60	5	5/50	В	А	Pass	
PE	±1	60	5	5/50	В	А	Pass	
L + N	±1	60	5	5/50	В	А	Pass	
L + PE	±1	60	5	5/50	В	А	Pass	
N + PE	±1	60	5	5/50	В	А	Pass	
L + N +PE	±1	60	5	5/50	В	А	Pass	
Remark:	No tempor entire test.	No temporary degradation or loss of function has been observed throughout the entire test.						

The Performance Requirement Class Criterion is defined in Sec. 1.11.

10.3.3 Observation of I/O, communication ports (Applicable only to cable length >3m)

There was no I/O and communication cable longer than 3 meter; therefore, no test has been required.

## PASS

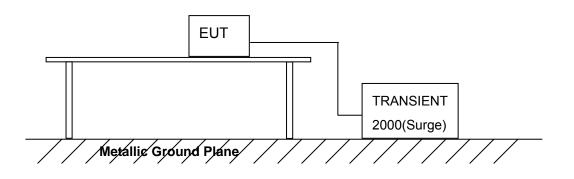
The test result shows that the EUT is in compliance with the test performance criteria specified in EN 55024.

## 11 Surge Immunity Test

#### 11.1 Test Instrument

Refer to Sec. 1.3 Test Instruments.

### **11.2 Test Configuration and Procedure**



#### Table-top Equipment

- The EUT was placed on a table of 0.8 m height above the 1 \* 1 m metallic ground reference plane, which projected beyond the EUT by at least 0.1 m on all sides.
- The ground plane was connected to the protective earth.
- The length of power cord between the coupling device and the EUT is less than 2 m (provided by the manufacturer).
- The EUT was connected to the power mains through a coupling device that directly couples the Surge interference signal. The surge noise was applied synchronized to the voltage phase at the zero crossing and the peak value of the AC voltage wave (positive and negative).
- The surges were applied line to line and line(s) to earth. When testing line to earth the test
  voltage was applied successively between each of the lines and earth. Steps up to the test
  level specified increased the test voltage. All lower levels including the selected test level were
  tested. The polarity of each surge level included positive and negative test pulses.
- Operating condition was shown on the monitor and observed.

### 11.3 Test Result

#### 11.3.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure
<b>24</b> .1℃	37%RH	1017mbar

### 11.3.2 Observation of Power Supply Port

	Test Specifications			Performance		
Coupling Selection	Voltage (kV)	Min. of Surge at Each Polarity	Repetition Rate (per min)	Required by EN 55024	Observed Result	Verdict
L►N	±0.5, 1	5	1	В	А	Pass
L ▶PE	±0.5, 1,2	5	1	В	А	Pass
N ►PE	±0.5, 1,2	5	1	В	А	Pass
Remark:	No temporary degradation or loss of function has been observed throughout the					
	entire test.					
Note	Phase Shift	ing:0°,90°,180°,2	70°,360°			

The Performance Requirement Class Criterion is defined in Sec. 1.11.

11.3.3 Observation of other supply/ signal lines: (Applicable only to ports which according to the manufacturer's specification may connect directly to outdoor cables)

N/A

## PASS

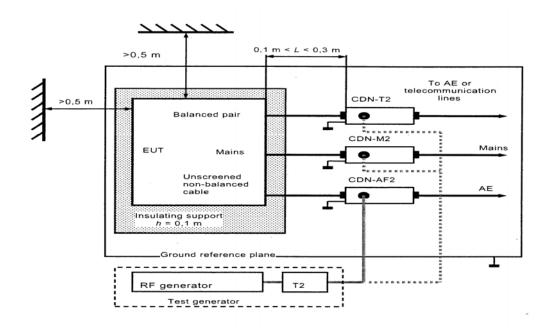
The test result shows that the EUT is in compliance with the test performance criteria specified in EN 55024.

# 12 Radio-frequency, Conducted Disturbances Immunity Test

### **12.1 Test Instruments**

Refer to Sec. 1.3 Test Instruments.

### 12.2 Test Configuration and Procedure



- The EUT was placed on an insulating support of 0.1 m height above a ground reference plane. All cables exiting the EUT was supported at a height of 30 mm above the ground reference plane.
- The EUT was connected to the power mains through a Coupling and Decoupling Networks (CDN).
- The CDN was located 0.3 m from the EUT as indicated in the diagram above.
- The test was performed with the test generator connected to each of the CDN in turn while the other non-excited RF input ports of the coupling devices were terminated by a 50 Ω terminator.
- The conducted disturbance was applied on the EUT from 150 kHz to 80 MHz using the signal levels established during the setting process.
- Operating condition was shown on the monitor and observed.

### 12.3 Test Result

#### 12.3.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure
<b>24</b> .1℃	37%RH	1017mbar

#### 12.3.2 Observation of Test

	Test Specifications			Performance		
Type of	Voltage Level	Frequency	Modulation	Required by	Observed	Verdict
Modulation	(emf) U <sub>0</sub>	Range	wouldtion	EN 55024	Result	verdict
Amplitude Modulation	3V/ 130dBµV	0.15 to 80MHz	80%, 1kHz, sinusoidal	A	A	Pass
Remark:	No temporary degradation or loss of function has been observed throughout the					
	entire test.					

The Performance Requirement Class Criterion is defined in Sec. 1.11.

#### 12.3.3 Observation of I/O, communication ports (Applicable only to cable length >3m)

There was no I/O and communication cable longer than 3 meter; therefore, no test has been required.

### PASS

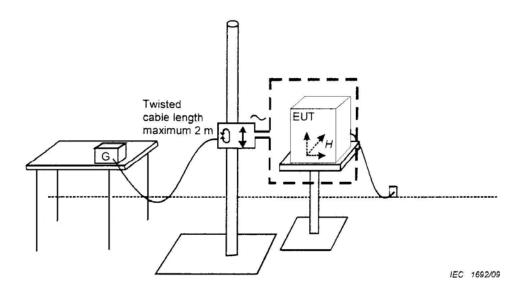
The test result shows that the EUT is in compliance with the test performance criteria specified in EN 55024.

## **13 Power Frequency Magnetic Field Immunity Test**

#### **13.1 Test Instruments**

Refer to Sec. 1.3 Test Instruments.

### 13.2 Test Configuration and Procedure



#### Table-top Equipment

- The EUT was placed on a non-magnetic metal ground plane of 0.25 mm thickness with the interposition of a 0.1 m thickness insulating support. The ground plane was connected to the protected earth.
- The EUT was placed at the center of the 1 \* 1 m induction coil with the test generator placed within 3 m distance.
- The test was operated by moving and shifting the induction coil to expose to the test field.
- The operation condition was observed and analyzed.
- The induction coil was then rotated by 90° to expose the EUT to the test field with different orientations and the same procedure.

### 13.3 Test Result

13.3.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure
<b>21.5</b> ℃	40%RH	1019mbar

### 13.3.2 Observation of Test

Level (A/m)	Frequency (Hz)	Performance Required by EN55024	Observed Result	Verdict	
1	50	А	А	Pass	
Remark:	No temporary degradation or loss of function has been observed				
	throughout the entire test.				

The Performance Requirement Class Criterion is defined in Sec. 1.11.

## PASS

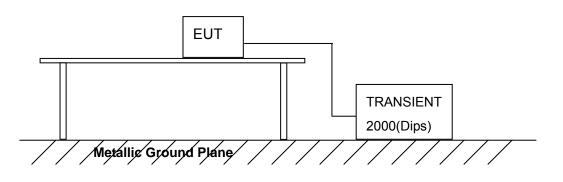
The test result shows that the EUT is in compliance with the test performance criteria specified in EN 55024.

## 14 Voltage Dips, Short Interruptions Immunity Test

#### 14.1 Test Instrument

Refer to Sec. 1.3 Test Instruments.

### 14.2 Test Configuration and Procedure



- The EUT was tested with (I) >95% voltage dip of supplied voltage with a duration of 10 ms (II) 30% voltage dip of supplied voltage with duration 500 ms (III) A 95% voltage interruption of supplied voltage with duration of 5000 ms,
- For each selected combination of test level and duration with a sequence of three dips / interruptions with intervals of 10 s.
- For Voltage Dips, changes in supply voltage occurred at zero crossings of the voltage.
- For Short Interruptions, changes in supply voltage also occurred at zero crossings of the voltage.
- The performance of the EUT was monitored and recorded.

### 14.3 Test Result

#### 14.3.1 Environment Condition

Т	emperature	Humidity	Atmospheric Pressure	
	<b>24.1</b> ℃	37%RH	1017mbar	

## 14.3.2 Observation of Power Supply Port

#### Voltage Dips

		Test Specificat	tions	Performance			
Voltage Reduction (%)	Duration Periods	No. of Reductions	Interval between Each Duration (sec.)	Required by EN 55024	Observed Result	Verdict	
>95	0.5	3	≥ 10	В	А	Pass	
30	25	3	≥ 10	С	А	Pass	
	entire tes 2. No ten	<ol> <li>No temporary degradation or loss of function has been observed throughout the entire test.</li> <li>No temporary degradation or loss of function has been observed throughout the entire test.</li> </ol>					
Note	Phase Sh	nifting:0°,180°, 360	)°				

### Voltage Interruptions

	Test Specifications			Performance		
Voltage Reduction (%)	Duration Periods	No. of Reductions	Interval between Each Duration (sec.)	Required by EN 55024	Observed Result	Verdict
>95	250	3	≥ 10	С	В	Pass
		When testing Voltage Dip with residual voltage 4% of normal power supply, the EUT				
	shut down automatically. After testing, the EUT recovered its function.					
Note	Phase SI	hifting:0°,180°, 360	ο			

The Performance Requirement Class Criterion is defined in Sec. 1.11.

## PASS

The test result shows that the EUT is in compliance with the test performance criteria specified in EN 55024.

# 15 Photographs of Test

**15.1 Conducted Disturbance Test (at Mains Terminals)** 



Front View



Rear View

## **15.2 Telecommunication Port Conducted Test**



## 15.3 Radiated Disturbance Test – Below 1 GHz



Front View



Rear View

## 15.4 Radiated Disturbance Test – Above 1 GHz



Front View



Rear View



## 15.5 Harmonic Current & Voltage Fluctuations and Flicker Measurement



## 15.6 Electrostatic Discharge Immunity Test



## 15.7 Radio-frequency, Electromagnetic Field Immunity Test



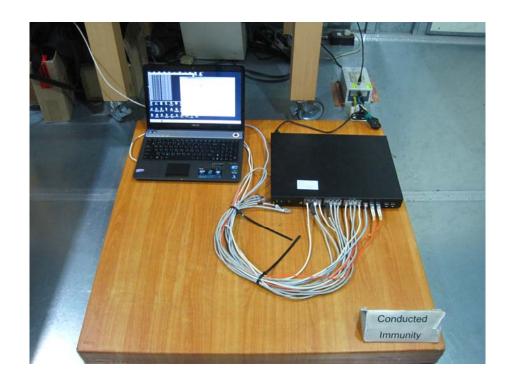
## 15.8 Electrical Fast Transient / Burst Immunity Test



## 15.9 Surge Immunity Test



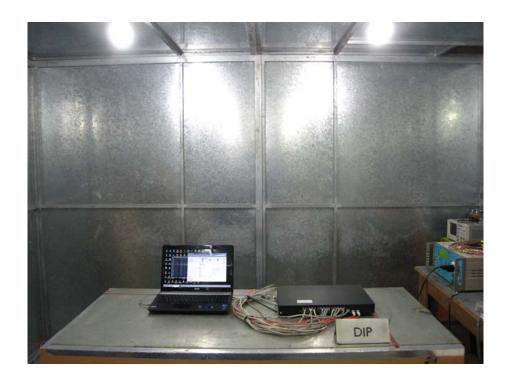
## 15.10 Radio-frequency, Conducted Disturbances Immunity Test



## 15.11 Power Frequency Magnetic Field Immunity Test



## 15.12 Voltage Dips, Short Interruptions Immunity Test



# 16 Photographs of EUT



Front View of the EUT

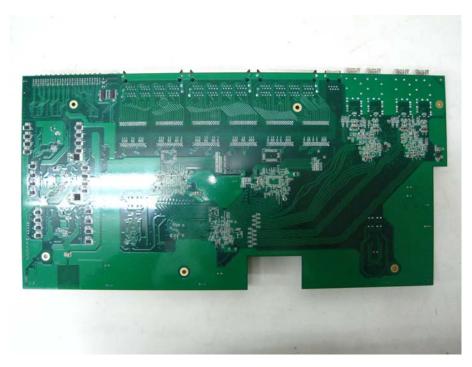


Rear View of the EUT



Inside View of the EUT



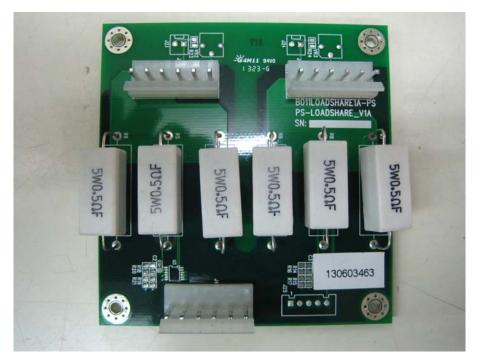


Rear View of the PCB 1





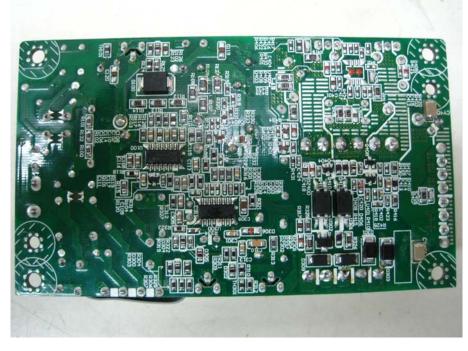
Rear View of the PCB 2





Rear View of the PCB 3





Rear View of the PCB 4



View of the Power Supply



View of the Power Cable



### View of ESD Test Points



### View of ESD Test Points





View of ESD Test Points



View of ESD Test Points